#### Etching Chemistry

- The etching process involves:
  - Transport of reactants to the surface
  - Surface reaction
  - Transport of products from the surface
- Key ingredients in any weterchant:
  - Oxidizer
    - examples: H<sub>2</sub>O<sub>2</sub>, HNO<sub>3</sub>
  - Acid or base to dissolve oxidized surface
    examples: H<sub>2</sub>SO<sub>4</sub>, NH<sub>4</sub>OH
  - Dillutent media to transport reactants and products through
    - examples: H<sub>2</sub>O, CH<sub>3</sub>COOH

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#### EE-527: MicroFabrication

Wet Etching

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#### Redox Reactions

- Etching is inherently an electrochemical process:
  - It involves electron transfer processes as part of the surface reactions.
- The <u>oxidation number</u> is the net positive charge on a species.
- Oxidation is the process of electron loss, or increase in the oxidation number.
- <u>Reduction</u> is the process of electron gain, or decrease in the oxidation number.
- Redox reactions are those composed of oxidation of one or more species and simultaneous reduction of others.

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#### Outline

- Isotropic Si etching
- · Anisotropic Si etching
- · Anisotropic GaAs etching
- Isotropic etching of SiO<sub>2</sub>, Al, and Cr
- · General features of wet chemical etching
- Selective etching and etch stops
- Interesting etch techniques
  - Junction diode etch stops
  - Field assisted etching
  - CMOS post processing

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#### HNA Etching of Silicon - 1

- <u>Hydrofluoric acid + Nitric acid + Acetic acid</u>
- Produces nearly isotropic etching of Si
- Overall reaction is:
  - $Si + HNO_3 + 6HF \rightarrow H_2SiF_6 + HNO_2 + H_2O + H_2$
  - Etching occurs via a redox reaction followed by dissolution of the oxide by an acid (HF) that acts as a complexing agent.
  - Points on the Si surface randomly become oxidation or reduction sites. These act like localized electrochemical cells, sustaining corrosion currents of ~100 A/cm<sup>2</sup> (relatively large).
  - Each point on the surface becomes both an anode and cathode site over time. If the time spent on each is the same, the etching will be uniform; otherwise selective etching will occur.

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#### Etch Anisotropy

- · Isotropic etching
  - Same etch rate in all directions
  - Lateral etch rate is about the same as vertical etch rate
  - Etch rate does not depend upon the orientation of the mask edge
- · Anisotropic etching

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- Etch rate depends upon orientation to crystalline planes
- Lateral etch rate can be much larger or smaller than vertical etch rate, depending upon orientation of mask edge to crystalline axes
- Orientation of mask edge and the details of the mask pattern determine the final etched shape
- · Can be very useful for making complex shapes
- · Can be very surprising if not carefully thought out
- · Only certain "standard" shapes are routinely used



falls of sharply for 1:1 HF:HNO<sub>3</sub> ratios. R. B. Darling / EE-527



## EDP Etching of Silicon - 3

- Requires reflux condenser to keep volatile ingredients from evaporating.
- Completely incompatible with MOS or CMOS processing!
  - It must be used in a fume collecting bench by itself.
  - It will rust any metal in the nearby vicinity.
  - It leaves brown stains on surfaces that are difficult to remove.
- EDP has a faster etch rate on convex corners than other anisotropic etches:
  - It is generally preferred for undercutting cantilevers.
  - It tends to leave a smoother finish than other etches, since faster etching of convex corners produces a polishing action.

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## KOH Etching of Silicon - 2

- · Simple hardware:
  - Hot plate & stirrer.
  - Keep covered or use reflux condenser to keep propanol from evaporating.
- Presence of alkali metal (potassium, K) makes this completely incompatible withMOS or CMOS processing!
- Comparatively safe and non-toxic.

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#### EDP Etching of Silicon - 4

- EDP etching can result in deposits of polymerizedSi(OH)<sub>4</sub> on the etched surfaces and deposits of Al(OH)<sub>3</sub> on Al pads.
- Moser's post EDP protocol to eliminate this:
  - 20 sec. DI water rinse
  - 120 sec. dip in 5% ascorbic acid (vitamin C) and  $H_{2}O$
  - 120 sec. rinse in DI water
  - 60 sec. dip in hexane,  $C_6H_{14}$

## EDP Etching of Silicon - 1

- Ethylene Diamine Pyrocatechol
- Also known as <u>E</u>thylene diamine <u>Pyrocatechol Water</u> (EPW)
- EDP etching is readily masked by SiQ, Si<sub>3</sub>N<sub>4</sub>, Au, Cr, Ag, Cu, and Ta. But EDP can etch Al!
- Anisotropy: (111):(100) ~ 1:35
- EDP is very corrosive, very carcinogenic, and never allowed near mainstream electronicmicrofabrication
- Typical etch rates for (100) silicon:

• Typical formulation:

- 6 g pyrazine, C<sub>4</sub>H<sub>4</sub>N<sub>2</sub>

- 133 mL H<sub>2</sub>O

- 1 L ethylene diamine, NH<sub>2</sub>-CH<sub>2</sub>-CH<sub>2</sub>-NH<sub>2</sub>

Oxidation of Si and reduction of water:

-  $\text{Si} + 2\text{OH}^- + 4\text{H}_2\text{O} \rightarrow \text{Si}(\text{OH})_6^{2-} + 2\text{H}_2$ 

 $- \mathrm{NH}_2(\mathrm{CH}_2)_2\mathrm{NH}_2 + \mathrm{H}_2\mathrm{O} \rightarrow \mathrm{NH}_2(\mathrm{CH}_2)_2\mathrm{NH}_3^+ + \mathrm{OH}^-$ 

-  $Si(OH)_{6}^{2-} + 3C_{6}H_{4}(OH)_{2} \rightarrow Si(C_{6}H_{4}O_{2})_{3}^{2-} + 6H_{2}O_{2}^{2-}$ 

- 160 g pyrocatechol, C<sub>6</sub>H<sub>4</sub>(OH)<sub>2</sub>

• Ionization of ethylene diamine:

• Chelation of hydrous silica:

70°C 14 μm/hr 80°C 20 μm/hr 90°C 30 μm/hr = 0.5 μm/min 97°C 36 μm/hr R. B.

EDP Etching of Silicon - 2

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pyrazine

ethylene diamine

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catechol

# Amine Gallate Etching of Silicon

- Much safer than EDP
- Typical recipe:
  - 100 g gallic acid
  - 305 mL ethanolamine
  - 140 mL H<sub>2</sub>O
  - 1.3 g pyrazine
  - 0.26 mL FC-129 surfactant
- Anisotropy: (111):(100): 1:50 to 1:100
- Etch rate:  $\sim 1.7 \ \mu m/min \ at \ 118^{\circ}C$

#### Anisotropic Etch Stop Layers - 1

- Controlling the absolute depth of an etch is often difficult, particularly if the etch is going most of the way through a wafer.
- Etch stop layers can be used to drastically slow the etch rate, providing a stopping point of high absolute accuracy.
- Boron doping is most commonly used for silicon etching.

## • Requirements for specific etches:

- HNA etch actually speeds up for heavier doping
- $-\,$  KOH etch rate reduces by 20× for boron doping  $>10^{20}\,cm^{\text{-}3}$
- $-\,$  NaOH etch rate reduces by 10× for boron doping  $> 3\times 10^{20}~cm^{-3}$
- EDP etch rate reduces by 50× for boron doping >  $7 \times 10^{19}$  cm<sup>-3</sup>
- TMAH etch rate reduces by 10× for boron doping >  $10^{20}$  cm<sup>-3</sup>

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- 250 mL TMAH (25% from Aldrich)
- 375 mL H<sub>2</sub>O
- 22 g Si dust dissolved into solution
- Use at 90°C
- Gives about 1  $\mu$ m/min etch rate

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tetramethyl ammonium hydroxide (TMAH)



# Electrochemical Etch Effects - 2

- HF normally etches SiO<sub>2</sub> and terminates on Si.
- By biasing the Si positively, holes can be injected by an external circuit which will oxidize theSi and form hydroxides which the HF can then dissolve.
- This produces an excellent polishing etch that can be very well masked by LPCVD films of S<sub>3</sub>N<sub>4</sub>.
- If the etching is performed in very concentrated HF (48% HF, 98% EtOH), then the Si does not fully oxidize when etched, and porous silicon is formed, which appears brownish.

